

Application/Control No.	Applicant(s)/Patent under Reexamination
10/802,002	HIROKAWA ET AL.
Examiner	Art Unit
Krishnan S. Menon	1723

	SEARCHED				
Class	Subclass	Date	Examiner		
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ראו	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search	5/15/2006	KM		
210/321.76, 321.85, 493.4, 497.1, 321.74, 321.83	5/15/2006	КМ		
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